



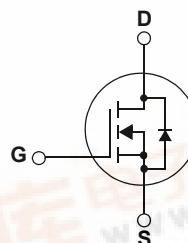
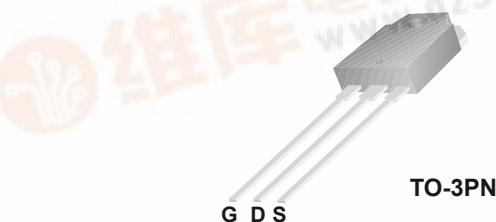
December 2007
UniFET™

FDA24N40F

N-Channel MOSFET, FRFET 400V, 23A, 0.19Ω

Features

- $R_{DS(on)} = 0.15\Omega$ (Typ.) @ $V_{GS} = 10V$, $I_D = 11.5A$
- Low gate charge (Typ. 46nC)
- Low C_{RSS} (Typ. 25pF)
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability
- RoHS compliant



MOSFET Maximum Ratings $T_C = 25^\circ C$ unless otherwise noted*

Symbol	Parameter		Ratings	Units
V_{DSS}	Drain to Source Voltage		400	V
V_{GSS}	Gate to Source Voltage		± 30	V
I_D	Drain Current	-Continuous ($T_C = 25^\circ C$)	23	A
		-Continuous ($T_C = 100^\circ C$)	13.8	
I_{DM}	Drain Current	- Pulsed (Note 1)	92	A
E_{AS}	Single Pulsed Avalanche Energy (Note 2)		1190	mJ
I_{AR}	Avalanche Current (Note 1)		23	A
E_{AR}	Repetitive Avalanche Energy (Note 1)		23.5	mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)		4.5	V/ns
P_D	Power Dissipation ($T_C = 25^\circ C$)	-	235	W
		- Derate above $25^\circ C$	1.8	$W/^\circ C$
T_J, T_{STG}	Operating and Storage Temperature Range		-55 to +150	$^\circ C$
T_L	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds		300	$^\circ C$

Thermal Characteristics

Symbol	Parameter	Min.	Max.	Units
$R_{\theta JC}$	Thermal Resistance, Junction to Case	-	0.53	$^\circ C/W$
$R_{\theta CS}$	Thermal Resistance, Case to Sink Typ.	0.24	-	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	-	40	

Package Marking and Ordering Information $T_C = 25^\circ\text{C}$ unless otherwise noted

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDA24N40F	FDA24N40F	TO-3PN	-	-	30

Electrical Characteristics

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
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Off Characteristics

BV_{DSS}	Drain to Source Breakdown Voltage	$I_D = 250\mu\text{A}, V_{GS} = 0\text{V}, T_J = 25^\circ\text{C}$	400	-	-	V
$\Delta \text{BV}_{\text{DSS}} / \Delta T_J$	Breakdown Voltage Temperature Coefficient	$I_D = 250\mu\text{A}, \text{Referenced to } 25^\circ\text{C}$	-	0.5	-	$\text{V}/^\circ\text{C}$
$I_{\text{DS}}^{\text{SS}}$	Zero Gate Voltage Drain Current	$V_{DS} = 400\text{V}, V_{GS} = 0\text{V}$	-	-	10	μA
		$V_{DS} = 320\text{V}, T_C = 125^\circ\text{C}$	-	-	100	
I_{GSS}	Gate to Body Leakage Current	$V_{GS} = \pm 30\text{V}, V_{DS} = 0\text{V}$	-	-	± 100	nA

On Characteristics

$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250\mu\text{A}$	3.0	-	5.0	V
$R_{DS(\text{on})}$	Static Drain to Source On Resistance	$V_{GS} = 10\text{V}, I_D = 11.5\text{A}$	-	0.15	0.19	Ω
g_{FS}	Forward Transconductance	$V_{DS} = 20\text{V}, I_D = 11.5\text{A}$ (Note 4)	-	29	-	S

Dynamic Characteristics

C_{iss}	Input Capacitance	$V_{DS} = 25\text{V}, V_{GS} = 0\text{V}$ $f = 1\text{MHz}$	-	2280	3030	pF
C_{oss}	Output Capacitance		-	370	490	pF
C_{rss}	Reverse Transfer Capacitance		-	25	38	pF
$Q_{g(\text{tot})}$	Total Gate Charge at 10V	$V_{DS} = 320\text{V}$ $I_D = 23\text{A}$	-	46	60	nC
Q_{gs}	Gate to Source Gate Charge		-	13	-	nC
Q_{gd}	Gate to Drain "Miller" Charge		(Note 4, 5)	-	18	-

Switching Characteristics

$t_{d(\text{on})}$	Turn-On Delay Time	$V_{DS} = 200\text{V}, I_D = 23\text{A}$ $R_G = 25\Omega$	-	40	90	ns
t_r	Turn-On Rise Time		-	92	195	ns
$t_{d(\text{off})}$	Turn-Off Delay Time		-	120	250	ns
t_f	Turn-Off Fall Time		(Note 4, 5)	-	75	160

Drain-Source Diode Characteristics

I_S	Maximum Continuous Drain to Source Diode Forward Current	-	-	23	A	
I_{SM}	Maximum Pulsed Drain to Source Diode Forward Current	-	-	92	A	
V_{SD}	Drain to Source Diode Forward Voltage	$V_{GS} = 0\text{V}, I_{SD} = 23\text{A}$	-	-	1.5	V
t_{rr}	Reverse Recovery Time	$V_{GS} = 0\text{V}, I_{SD} = 23\text{A}$ $dI_F/dt = 100\text{A}/\mu\text{s}$	-	110	-	ns
Q_{rr}	Reverse Recovery Charge		(Note 4)	-	0.3	μC

Notes:

- 1: Repetitive Rating: Pulse width limited by maximum junction temperature
- 2: $L = 4.5\text{mH}, I_{AS} = 23\text{A}, V_{DD} = 50\text{V}, R_G = 25\Omega$, Starting $T_J = 25^\circ\text{C}$
- 3: $I_{SD} \leq 23\text{A}, dI/dt \leq 200\text{A}/\mu\text{s}, V_{DD} \leq \text{BV}_{\text{DSS}}$, Starting $T_J = 25^\circ\text{C}$
- 4: Pulse Test: Pulse width $\leq 300\mu\text{s}$, Duty Cycle $\leq 2\%$
- 5: Essentially Independent of Operating Temperature Typical Characteristics

Typical Performance Characteristics

Figure 1. On-Region Characteristics

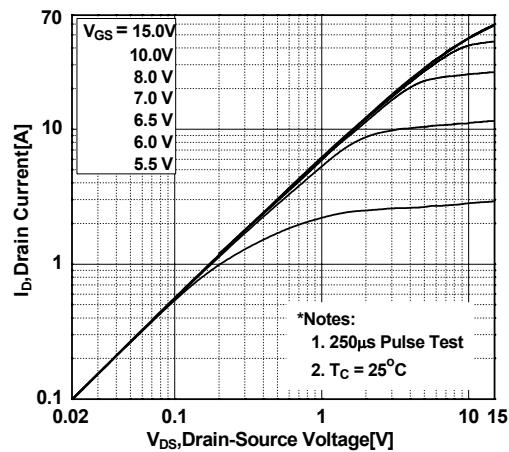


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

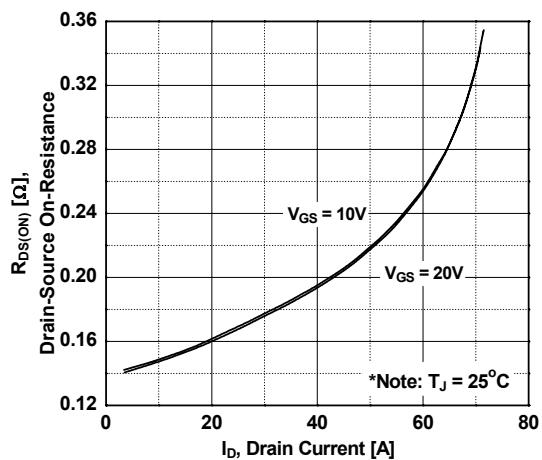


Figure 5. Capacitance Characteristics

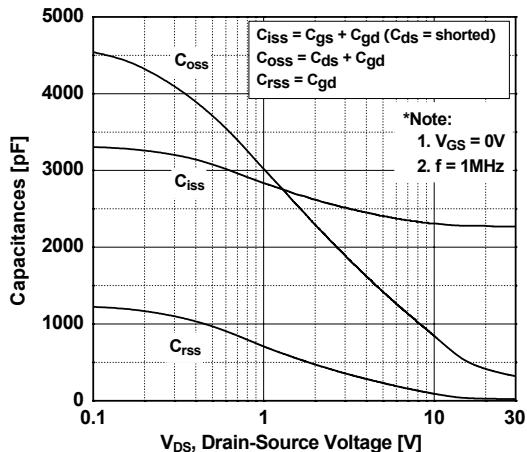


Figure 2. Transfer Characteristics

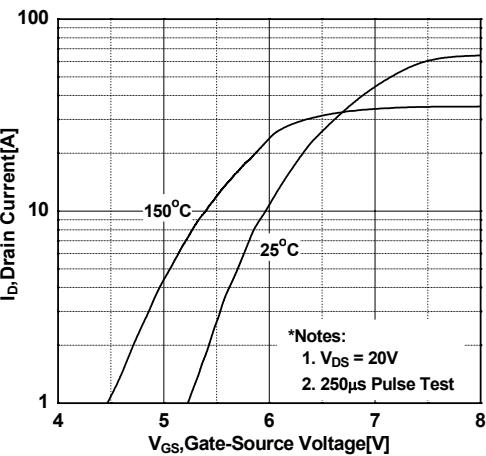


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

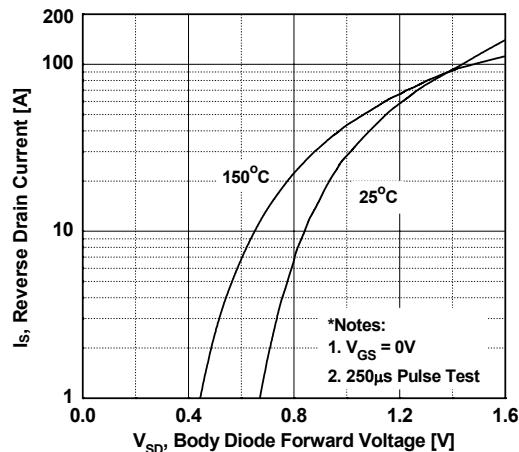
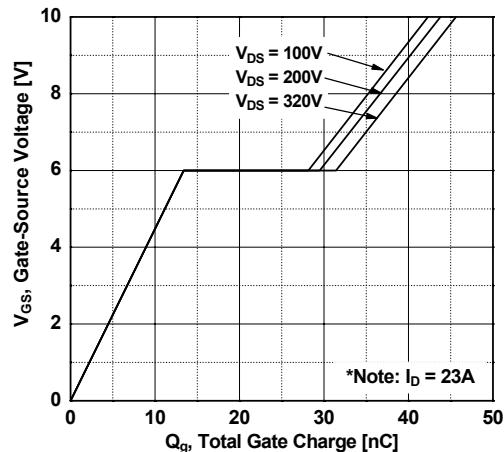


Figure 6. Gate Charge Characteristics



Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

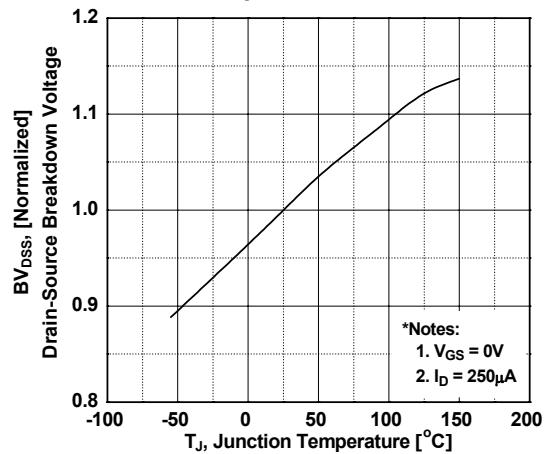


Figure 8. Maximum Safe Operating Area

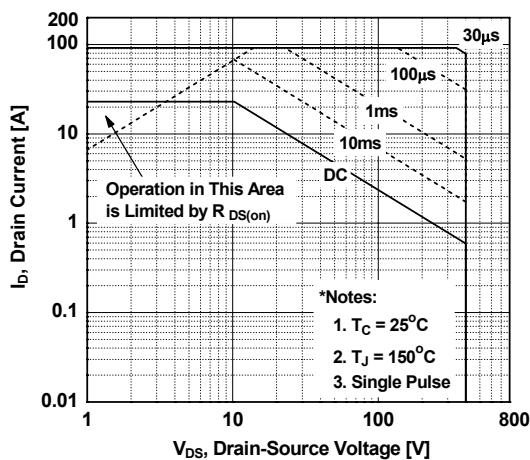


Figure 9. Maximum Drain Current vs. Case Temperature

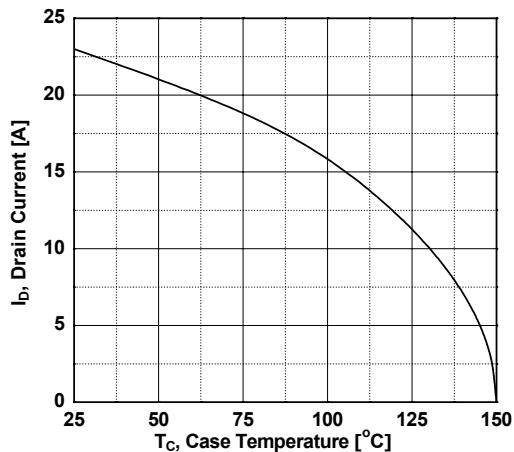
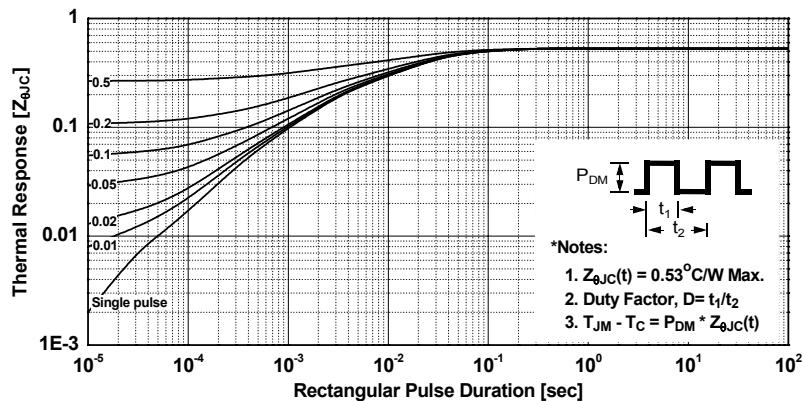
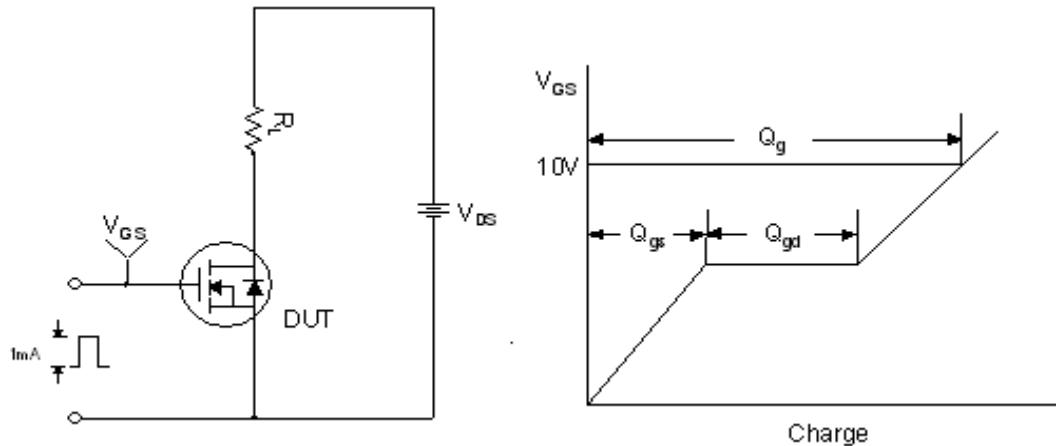


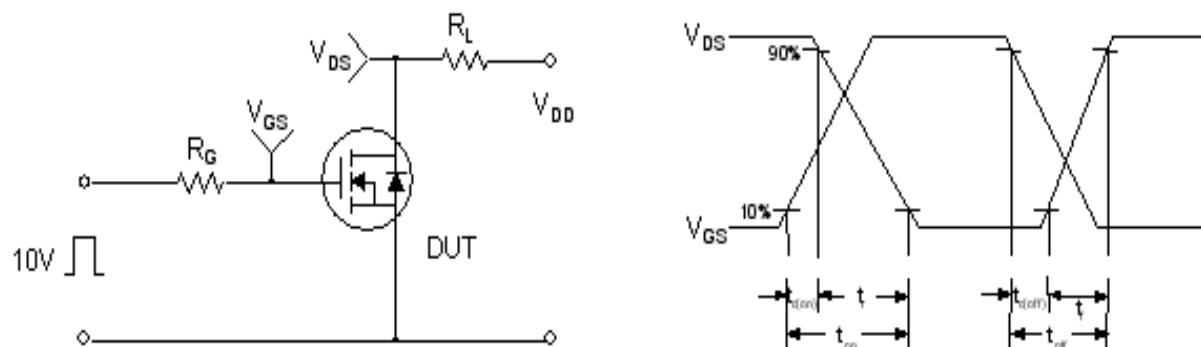
Figure 10. Transient Thermal Response Curve



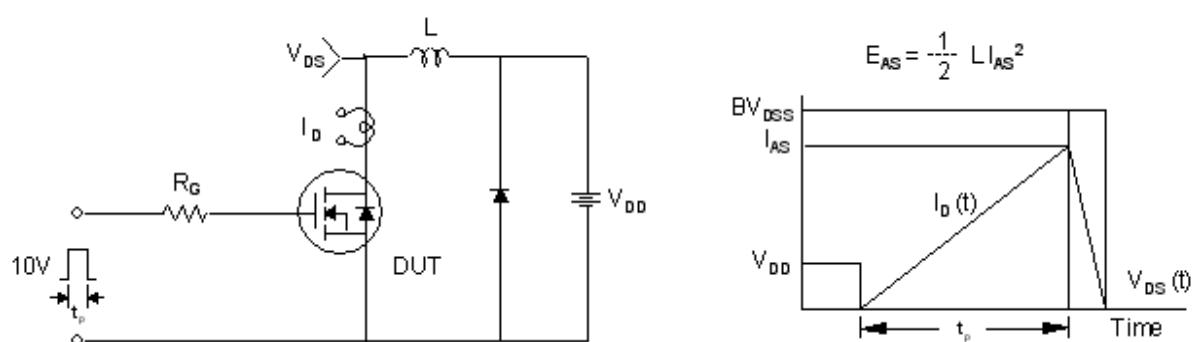
Gate Charge Test Circuit & Waveform



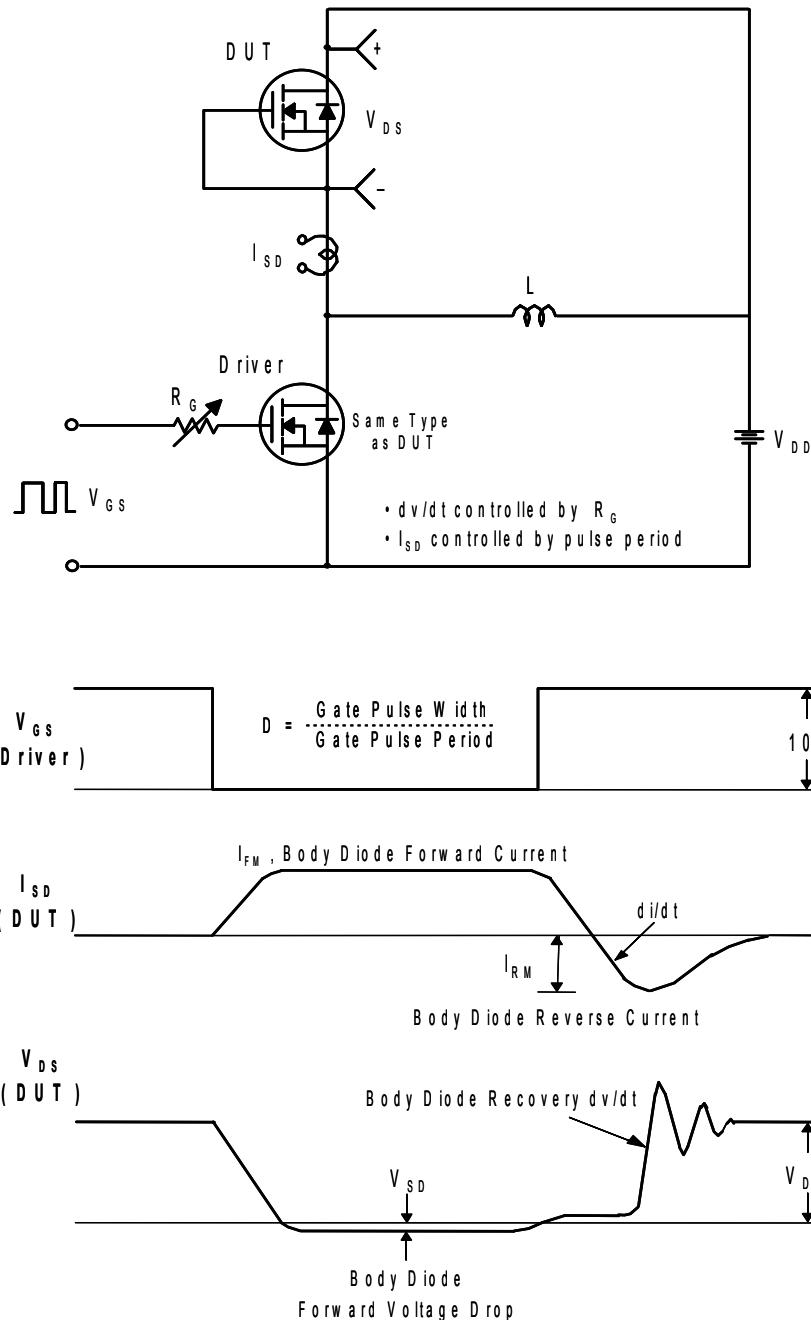
Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching Test Circuit & Waveforms

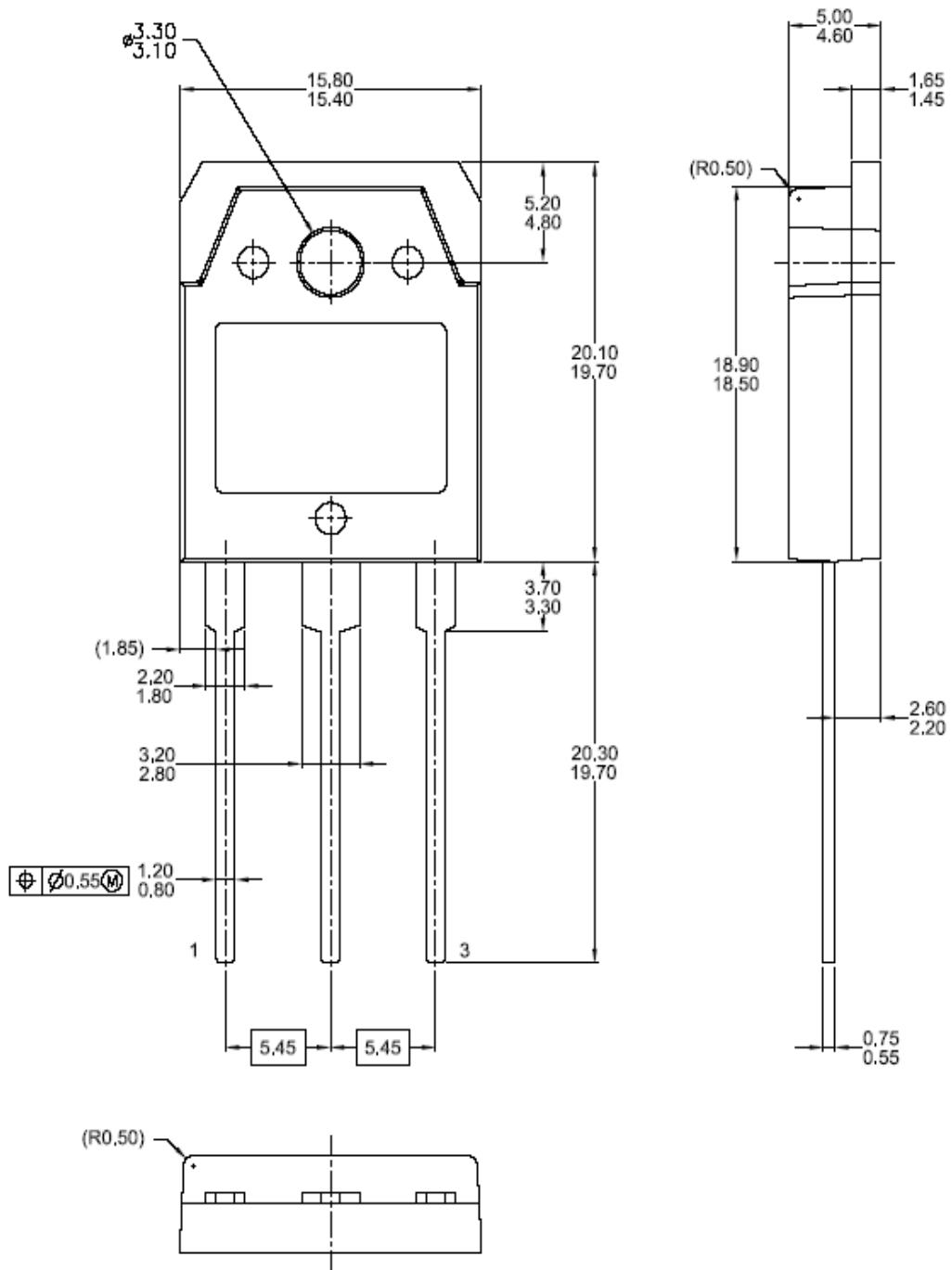


Peak Diode Recovery dv/dt Test Circuit & Waveforms



Mechanical Dimensions

TO-3PN



Dimensions in Millimeters



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